

Search Notes

Application/Control No.

10/530,285

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

BETEILLE, FABIEN

Art Unit

1792

SEARCHED

Class	Subclass	Date	Examiner
216	33	8/29/2008	BT
216	59	8/29/2008	BT
216	65	8/29/2008	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search keywords and inventor's names using databases in EAST	8/29/2008	BT